

2007-03-26 14:00:00

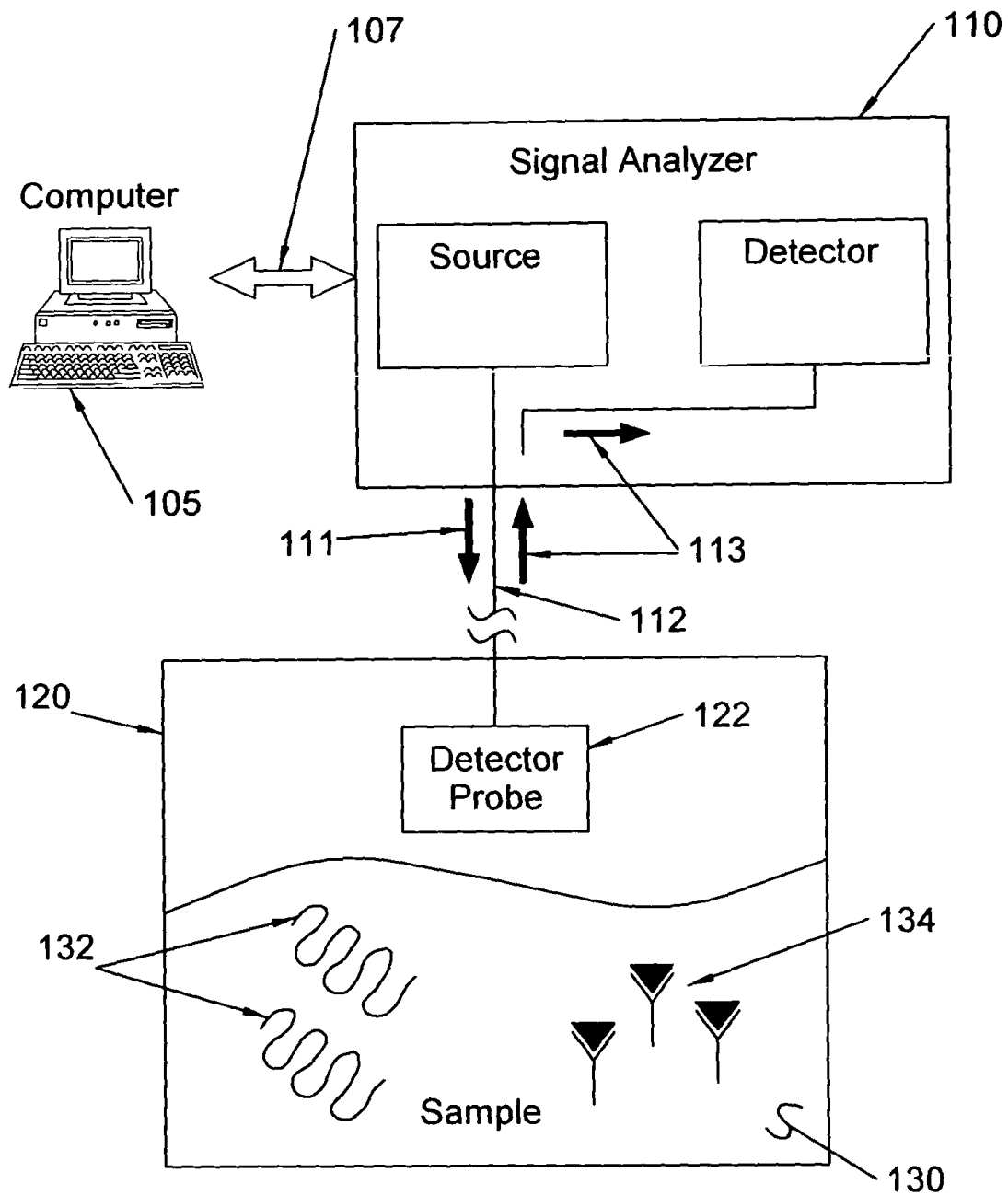


FIG. 1

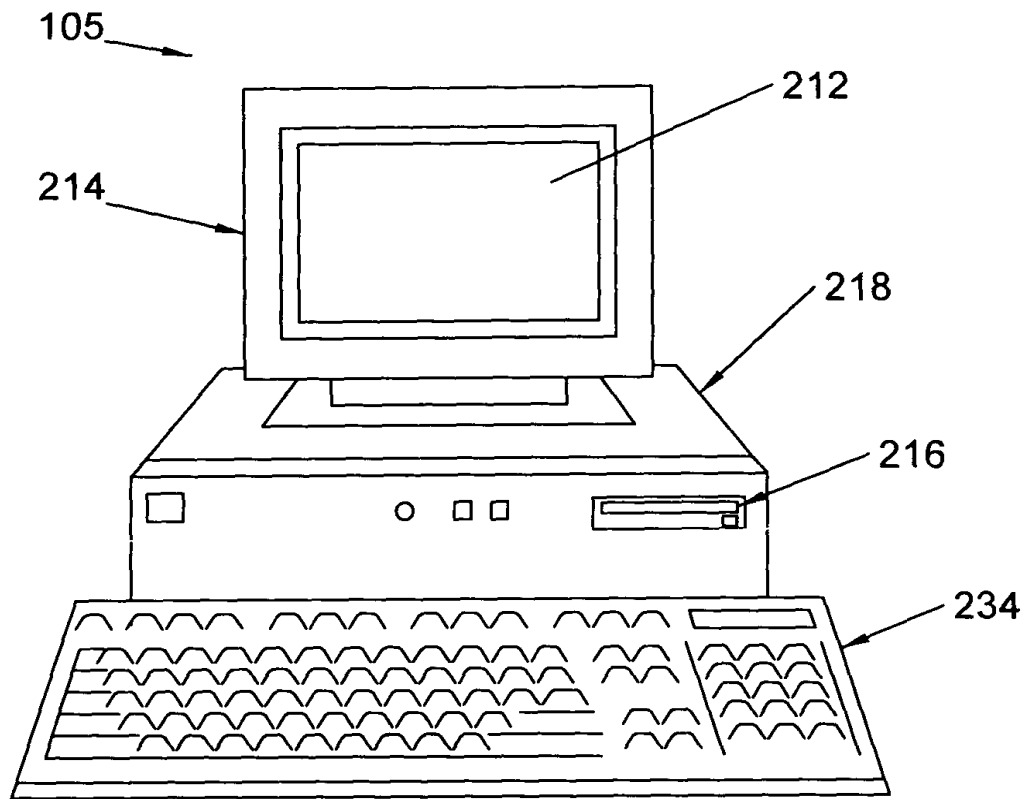


FIG. 2A

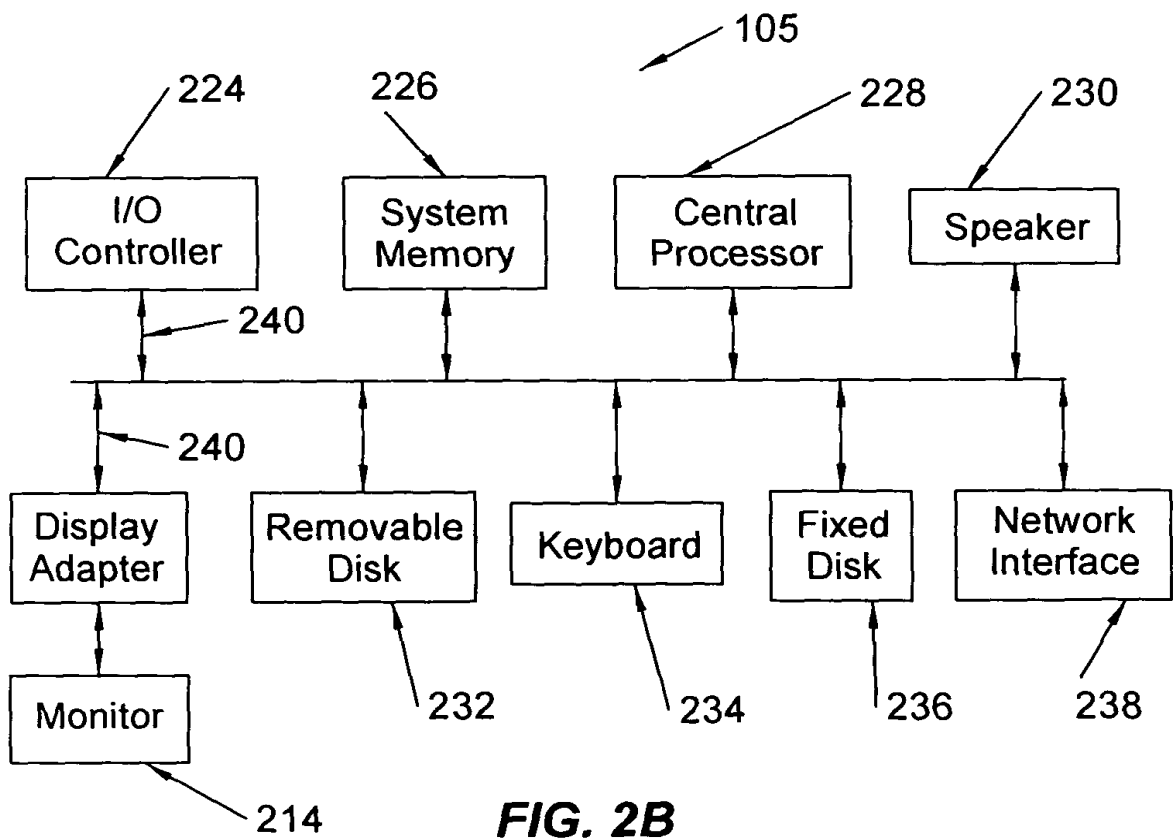


FIG. 2B

FIG. 3A

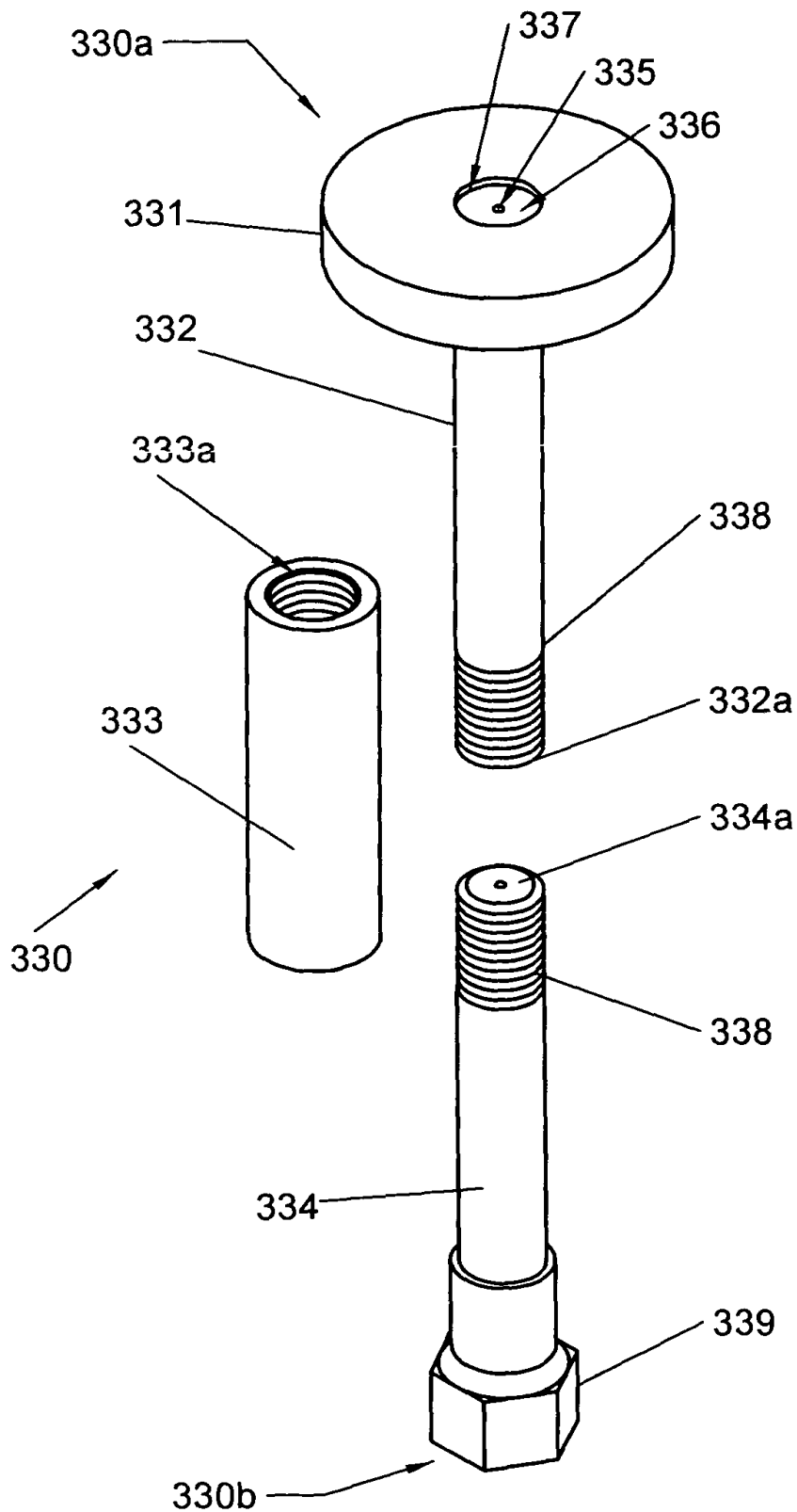


FIG. 3A

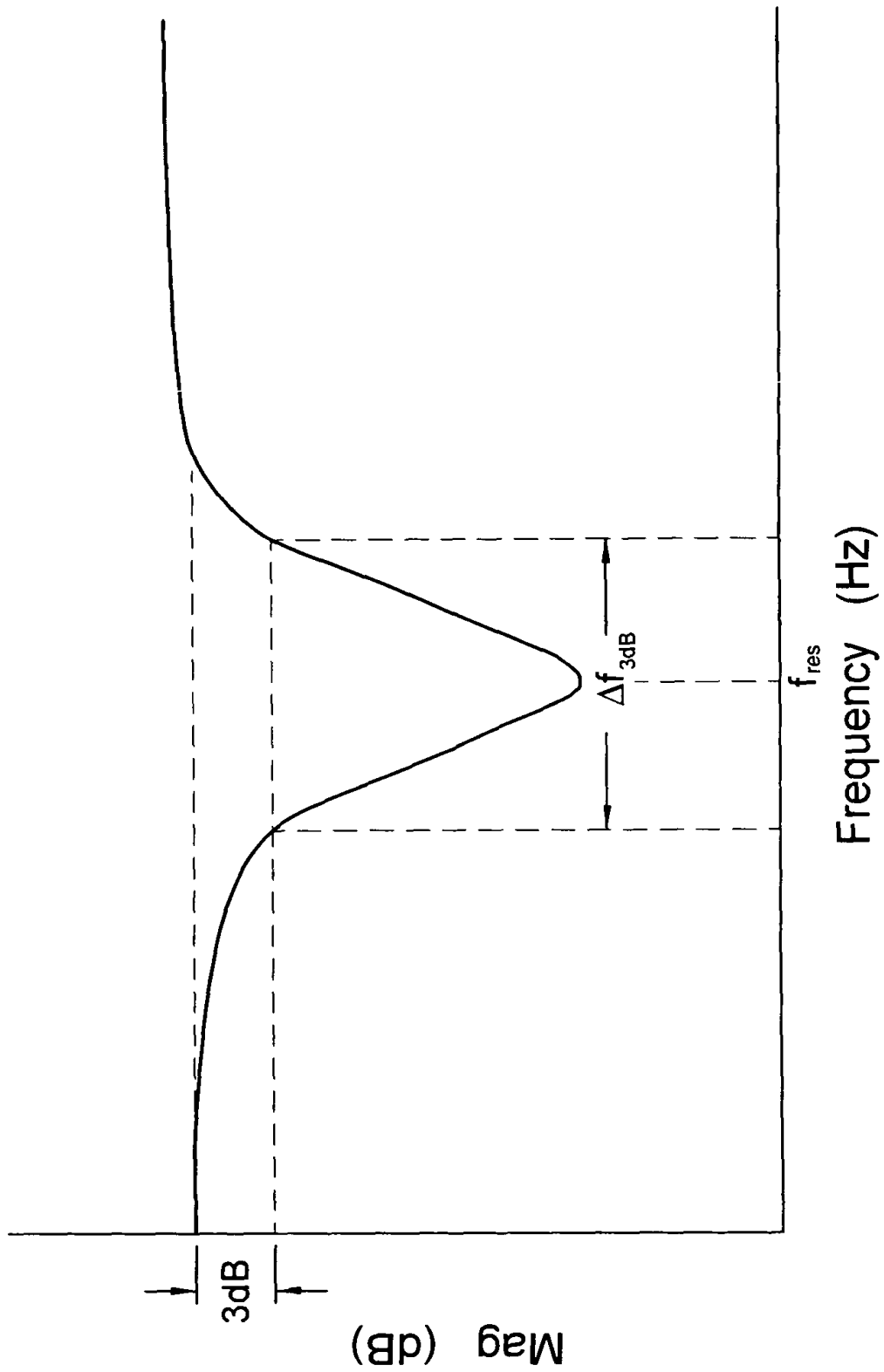


FIG. 3B

2025-03-27 10:00:00

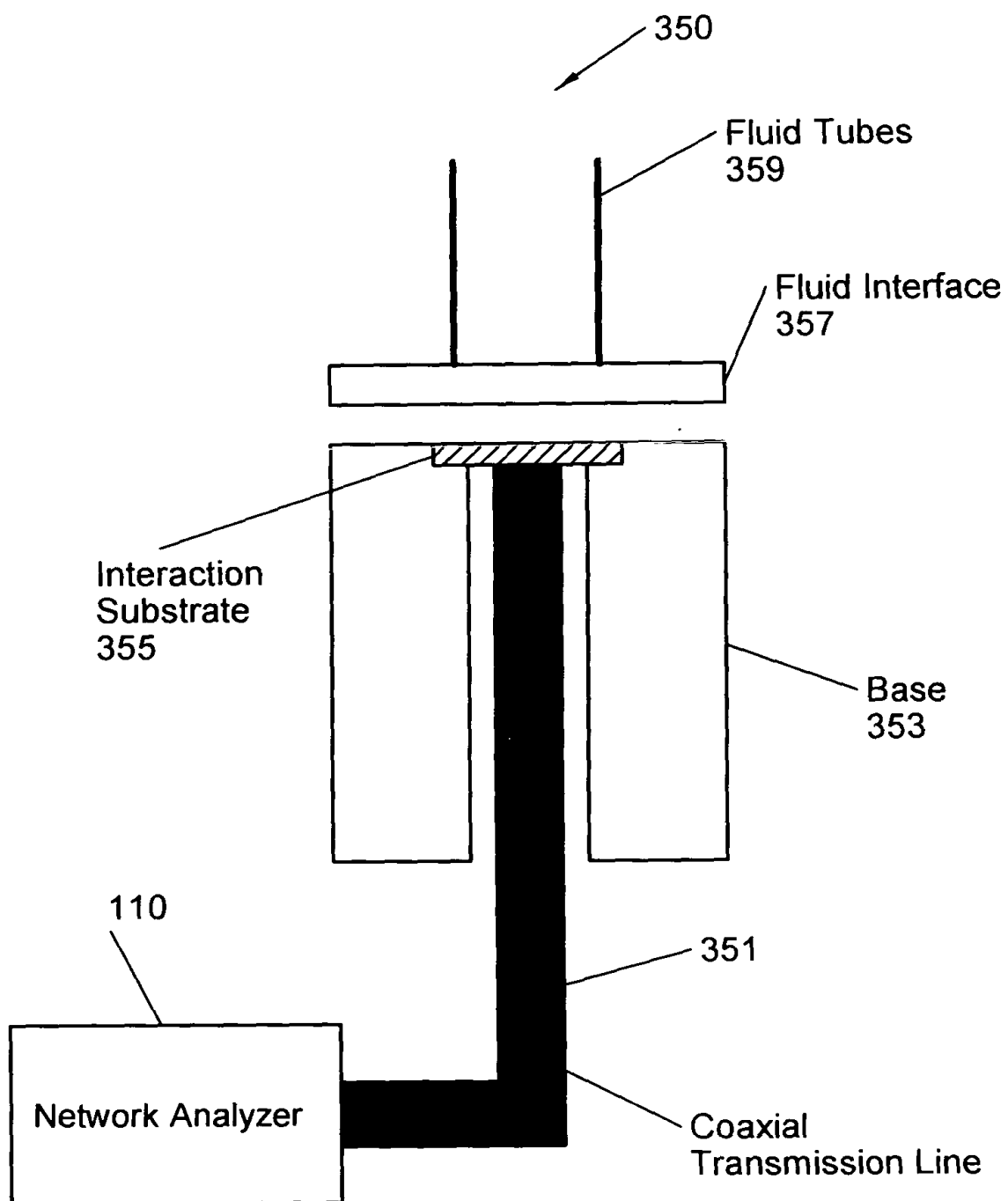


FIG. 3C

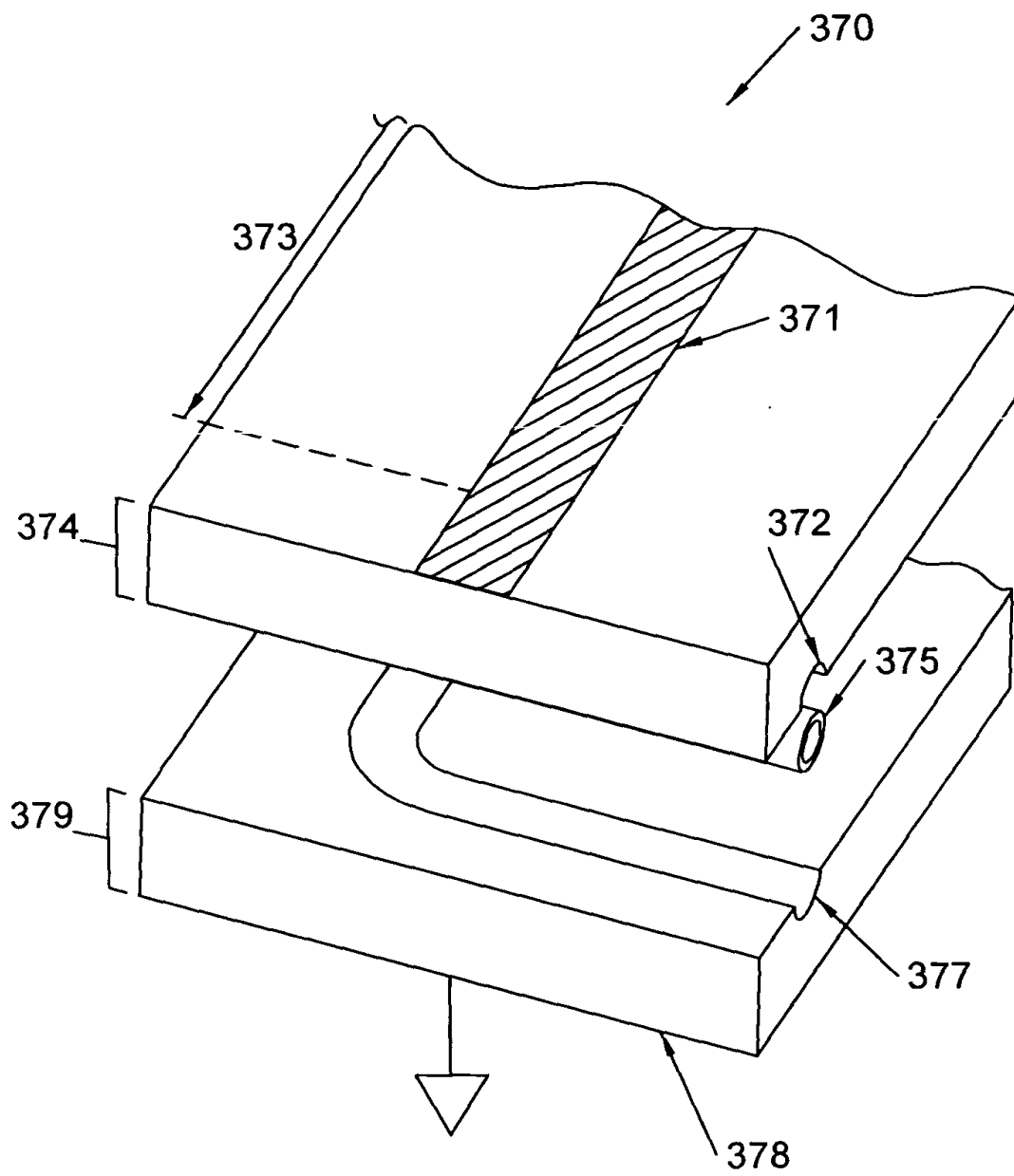


FIG. 3D

FIG. 4A

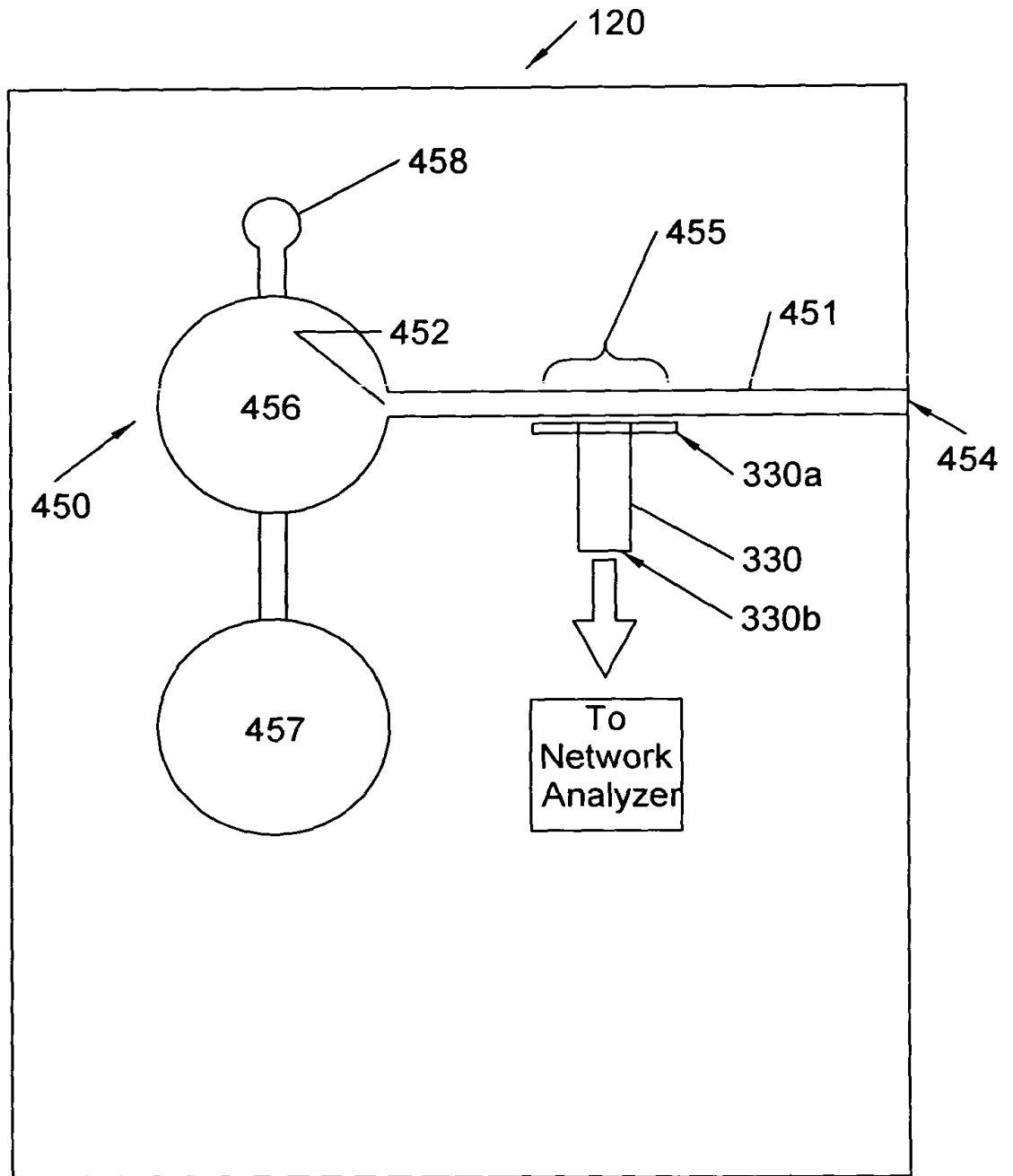


FIG. 4A

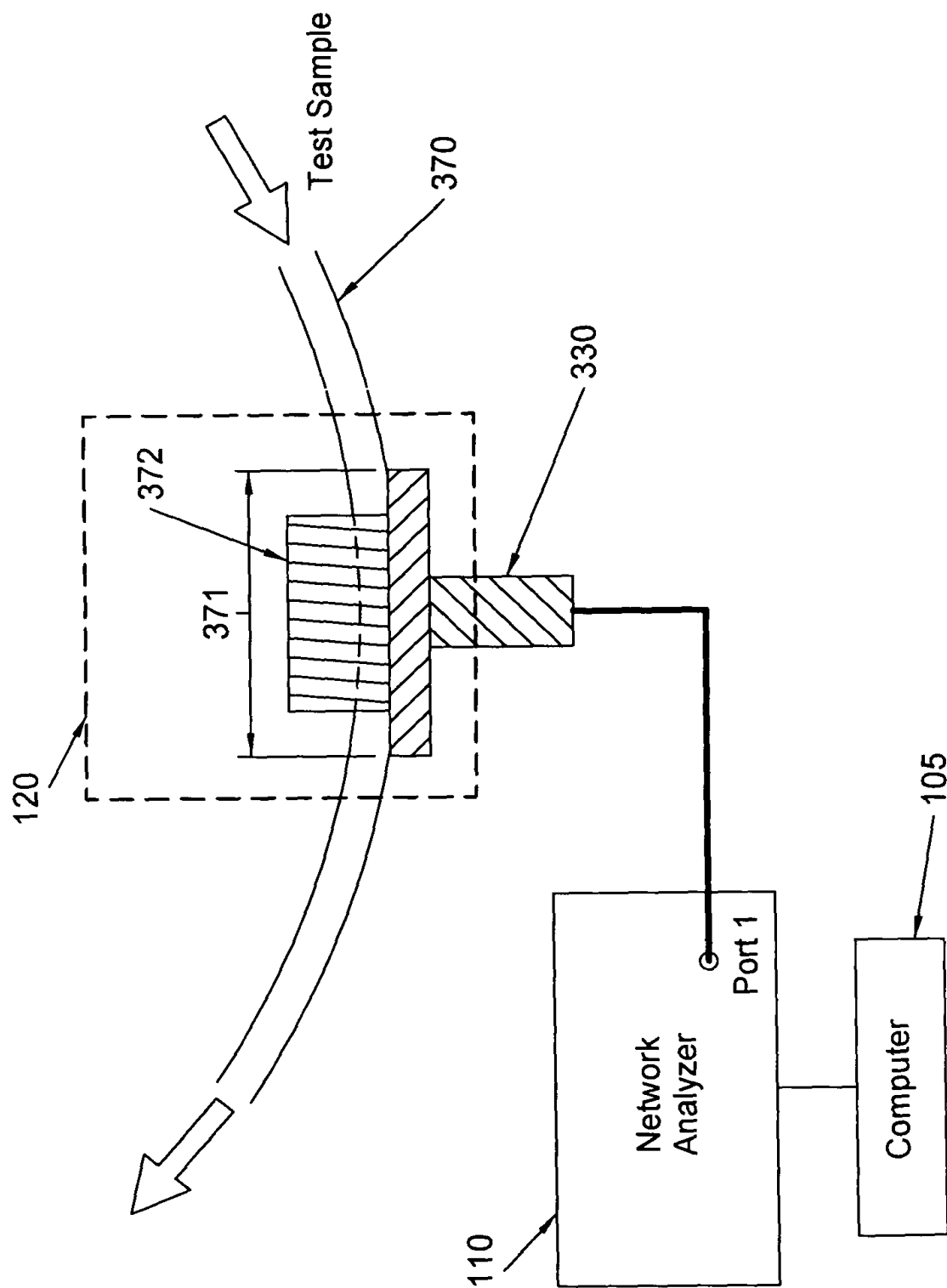


FIG. 4B

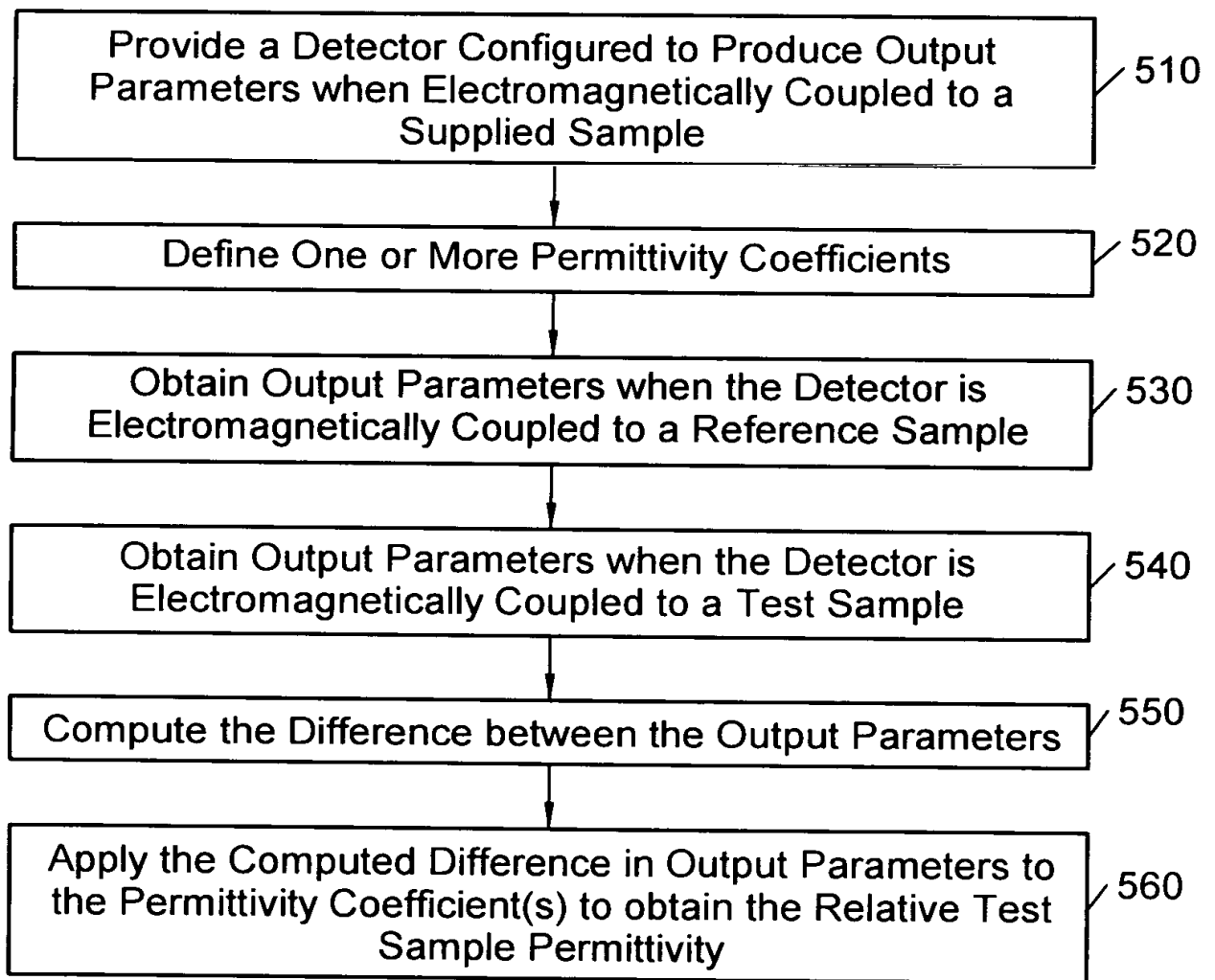


FIG. 5

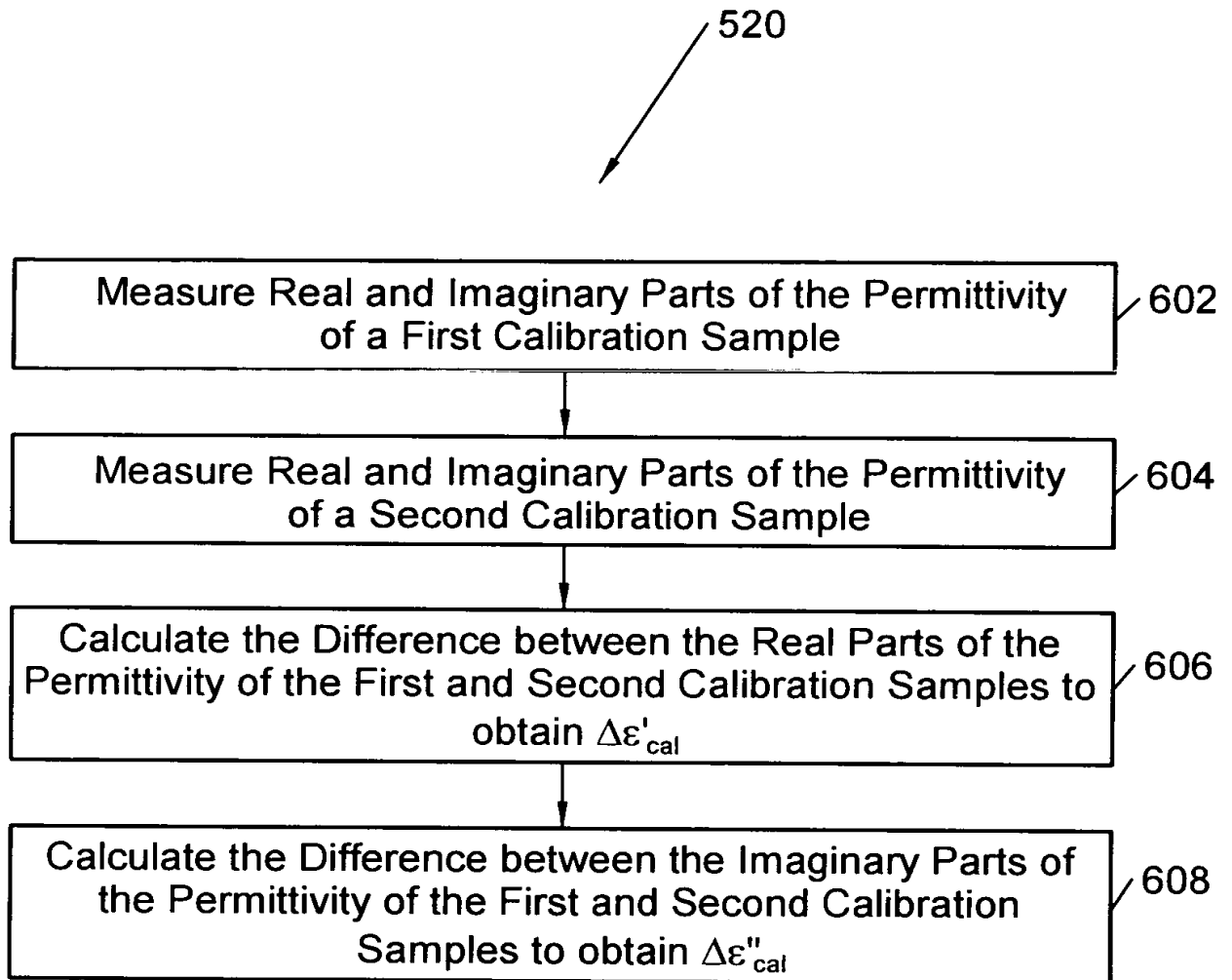


FIG. 6

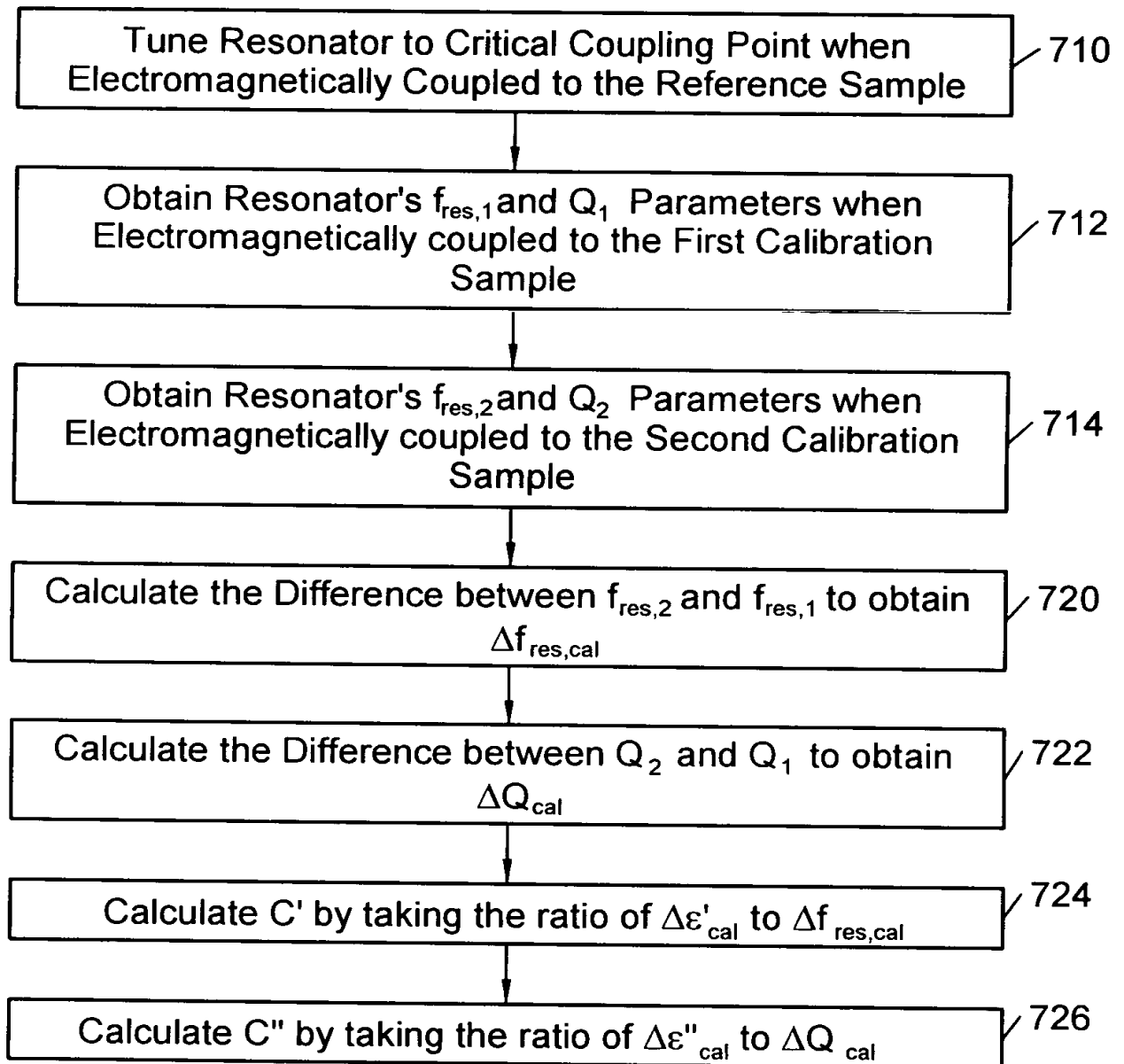


FIG. 7A

540, 550

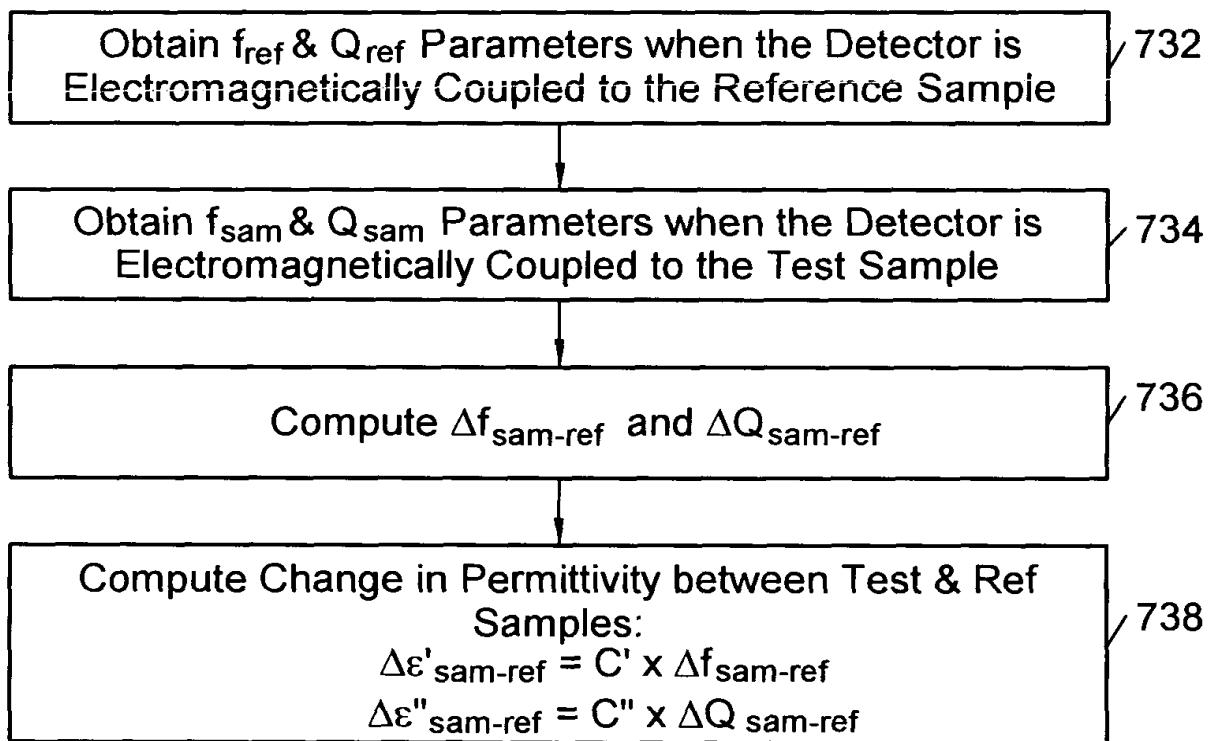
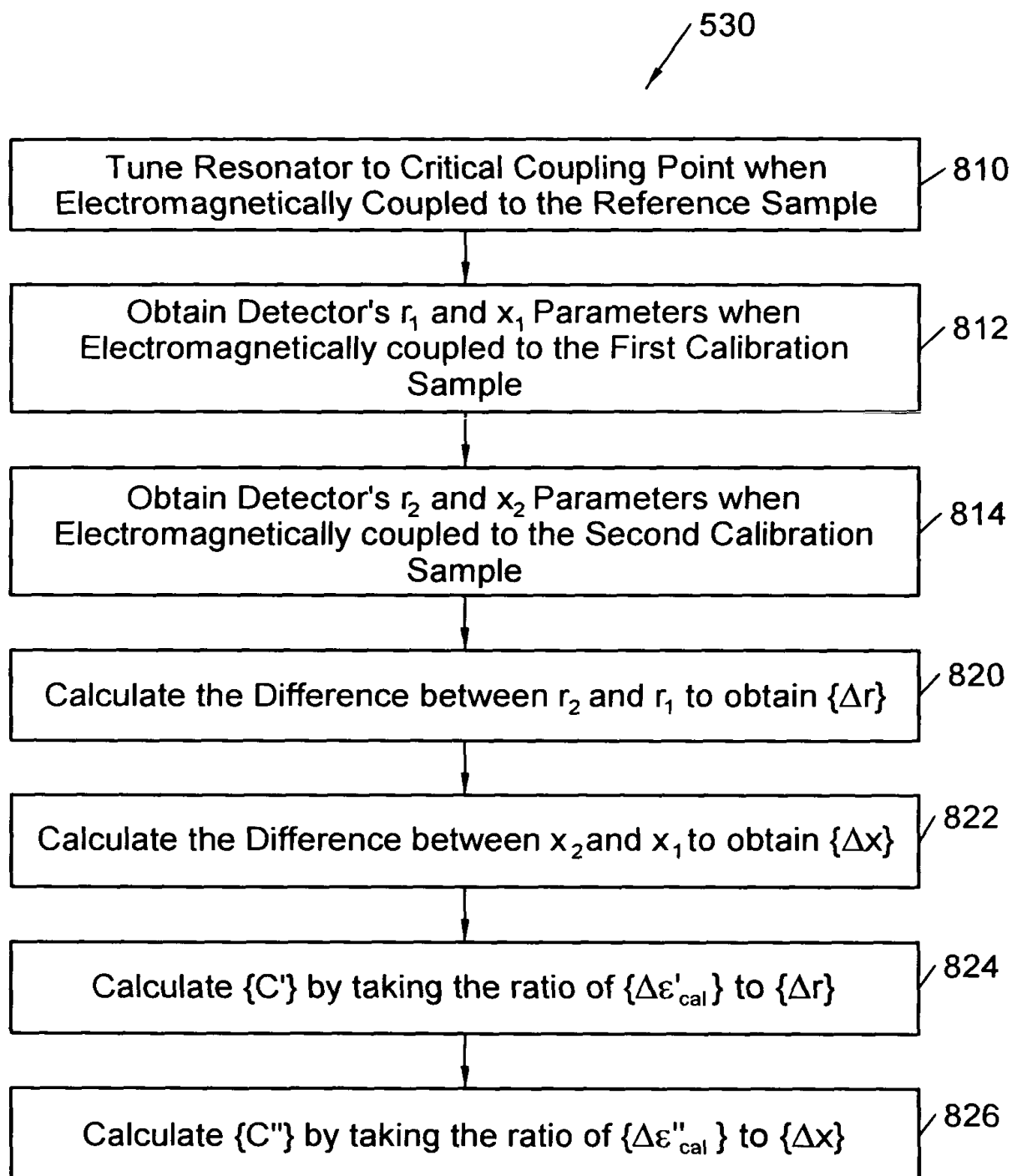


FIG. 7B

**FIG. 8A**

540, 550

Obtain r_{ref} & x_{ref} Parameters when the Detector is Electromagnetically Coupled to the Reference Sample

832

Obtain r_{sam} & x_{sam} Parameters when the Detector is Electromagnetically Coupled to the Test Sample

834

Compute $\{\Delta x_{\text{sam-ref}}\}$ and $\{\Delta r_{\text{sam-ref}}\}$

836

Compute Change in Permittivity between Test & Ref Samples:

838

$$\begin{aligned}\{\Delta \epsilon'_{\text{sam-ref}}\} &= \{C'\} \times \{\Delta r_{\text{sam-ref}}\} \\ \{\Delta \epsilon''_{\text{sam-ref}}\} &= \{C''\} \times \{\Delta x_{\text{sam-ref}}\}\end{aligned}$$

FIG. 8B

FIG. 9A

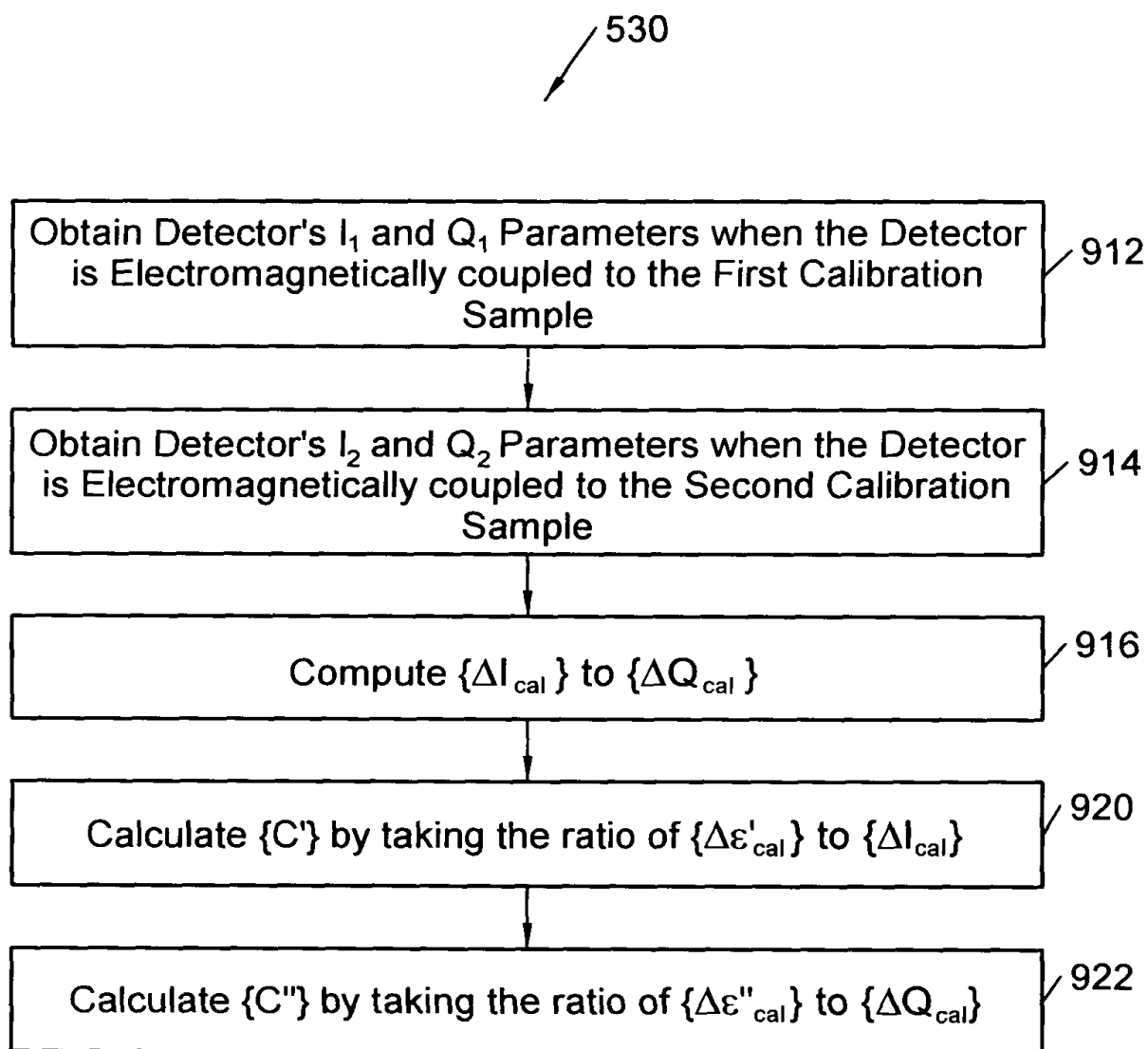


FIG. 9A

540, 550

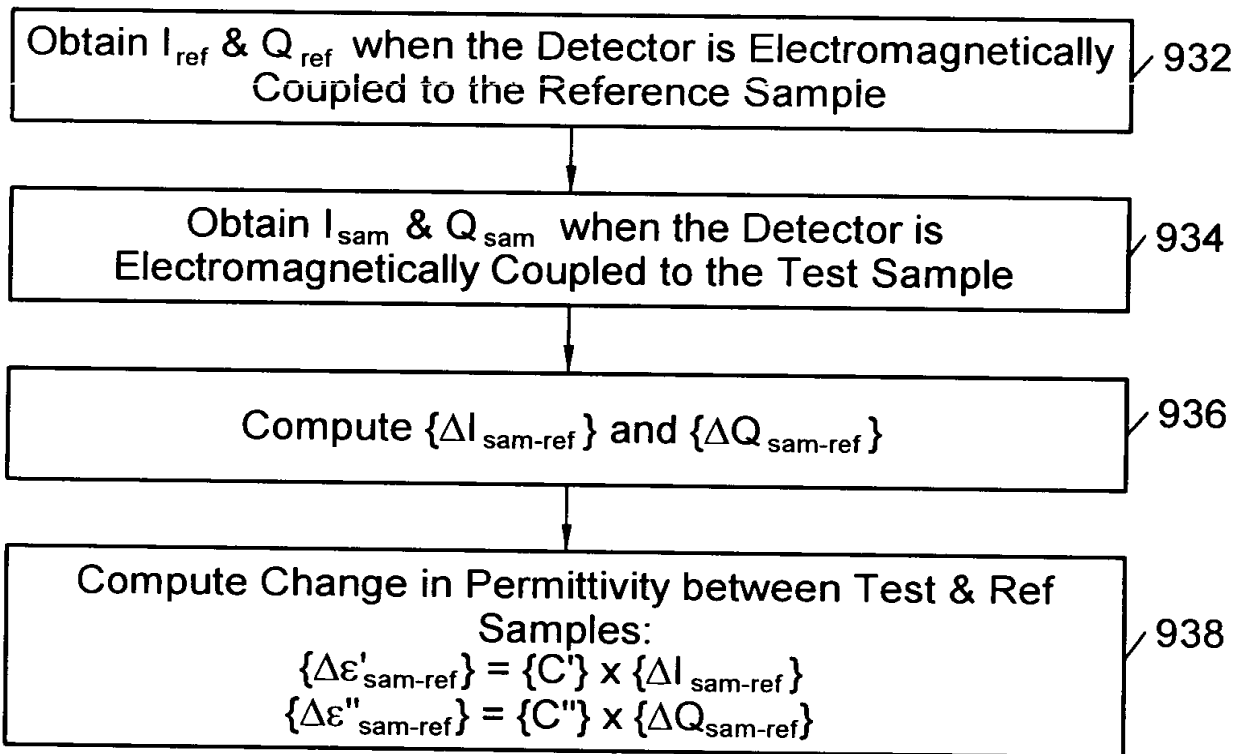


FIG. 9B

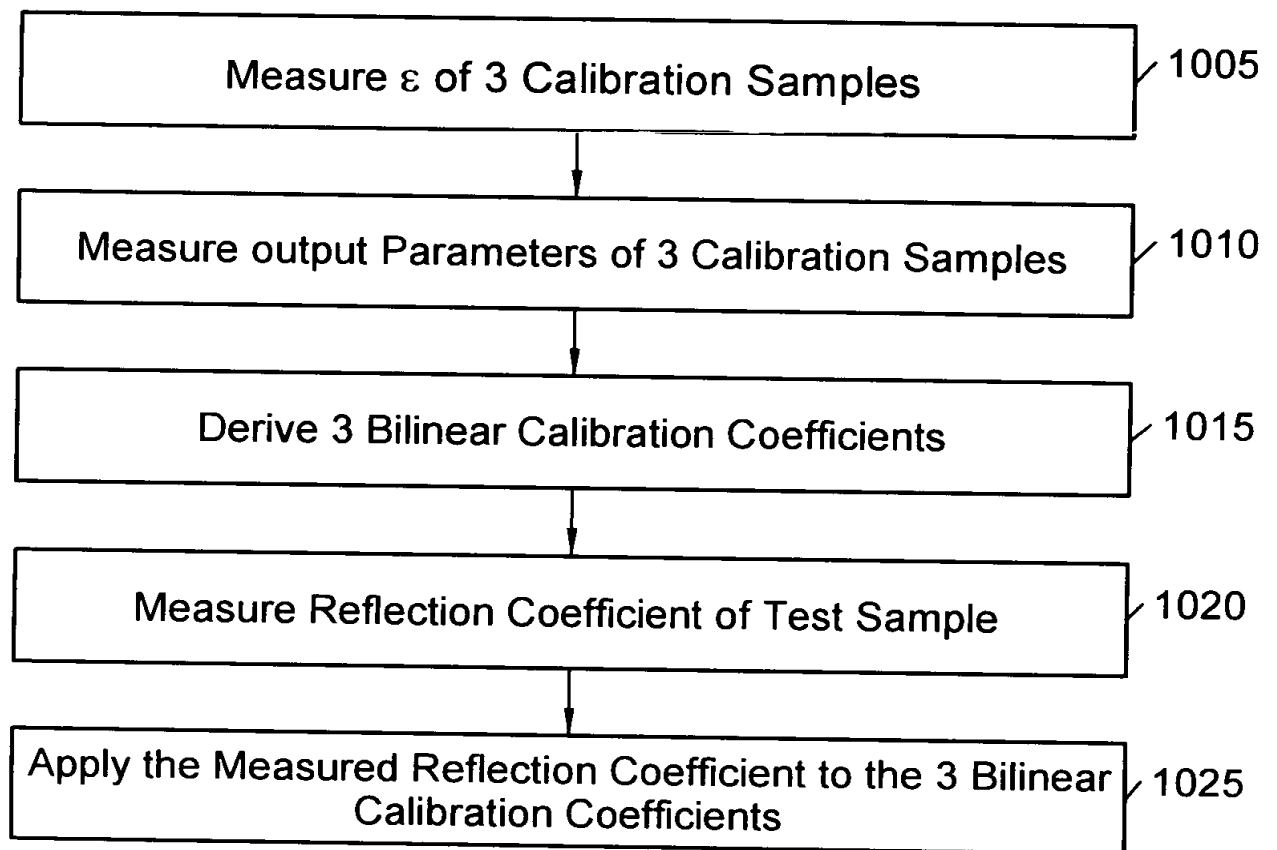


FIG. 10

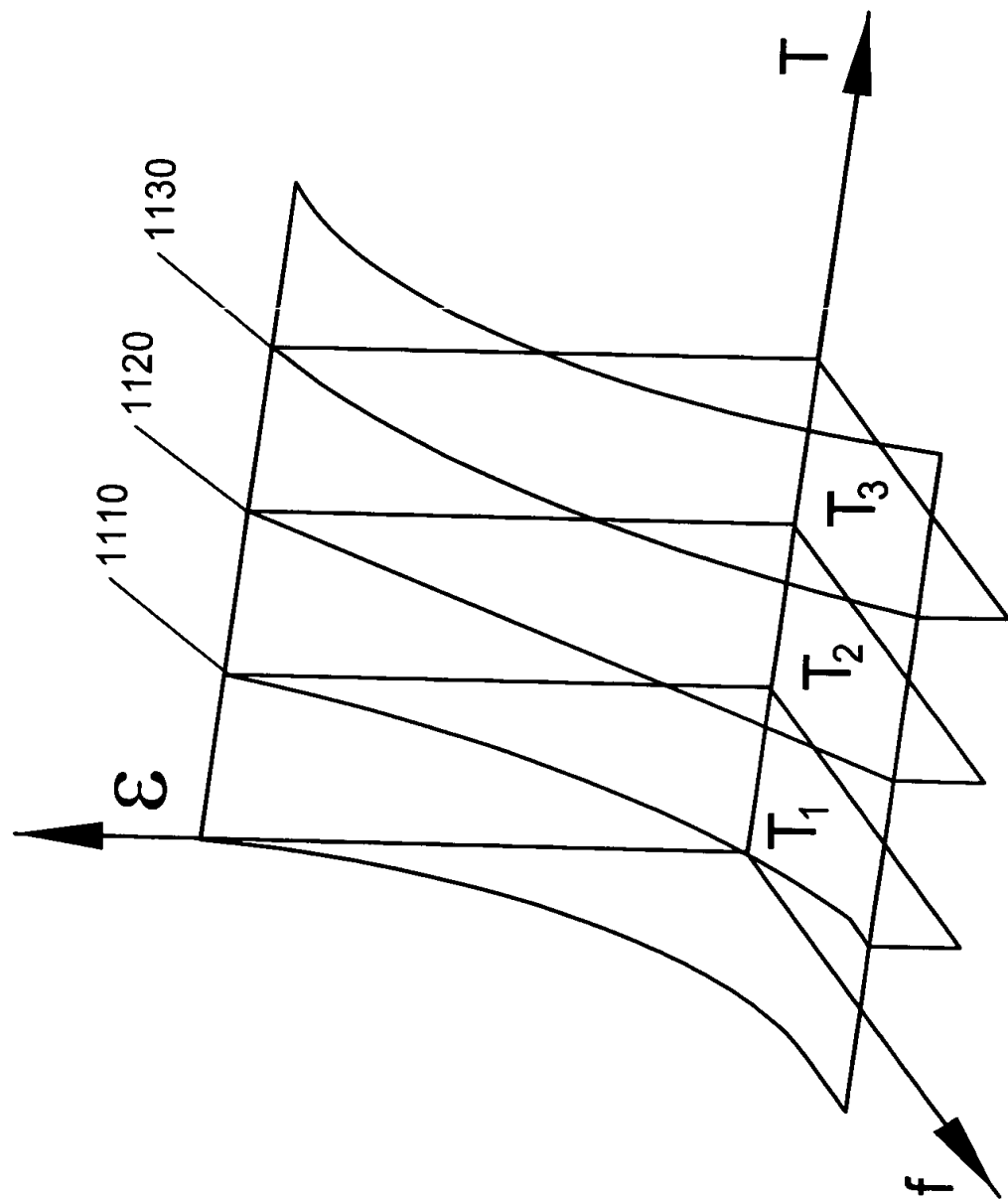


FIG. 11

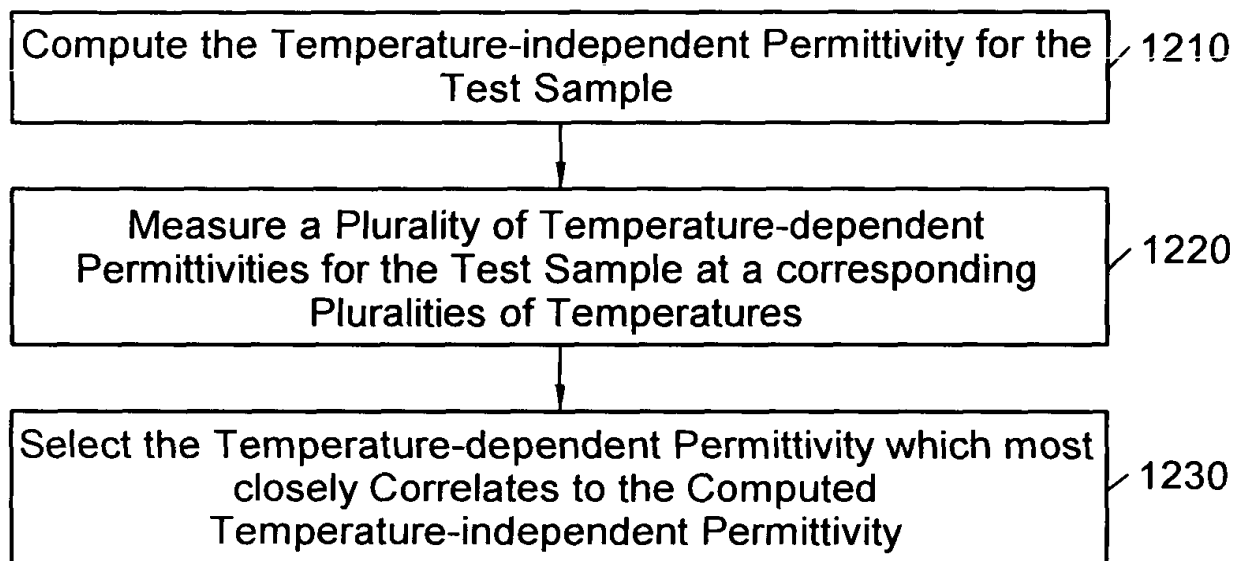


FIG. 12A

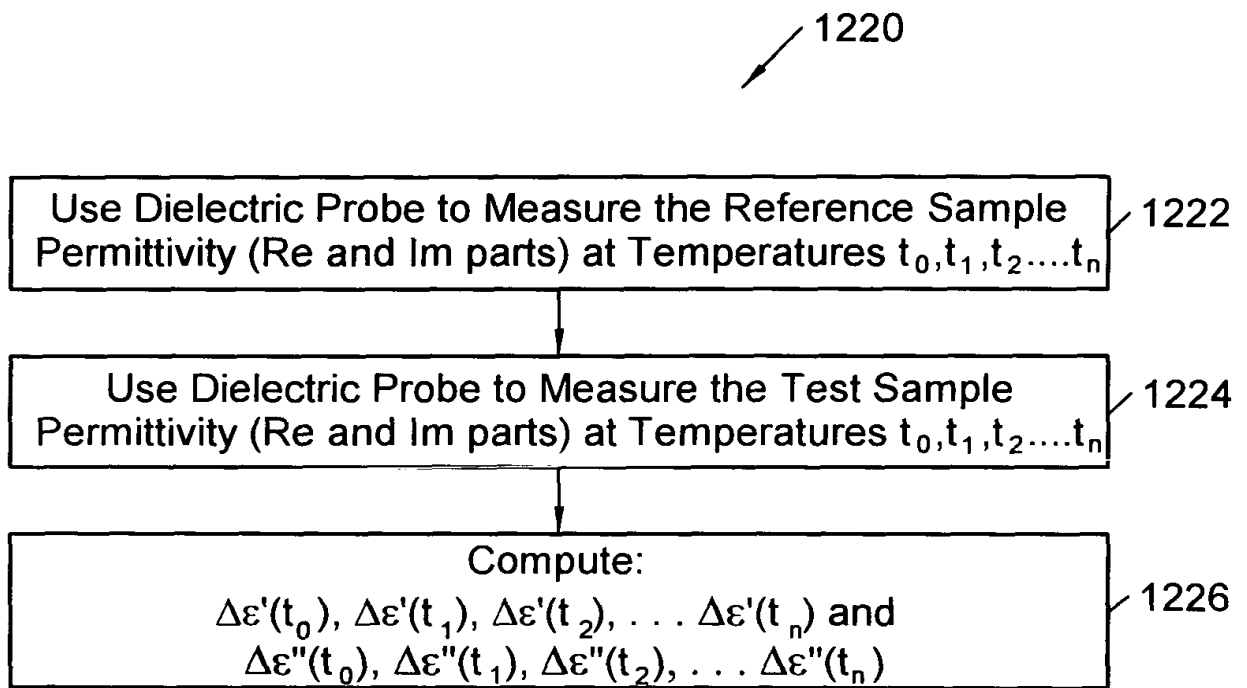


FIG. 12B

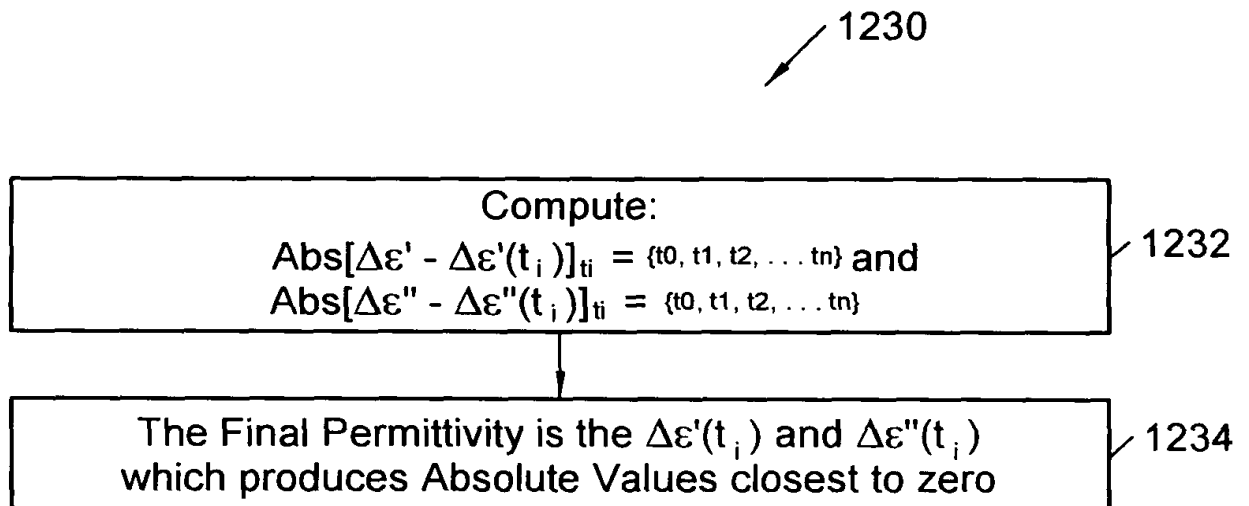


FIG. 12C